

10/501310
 DTG 13 JUL 2004

INFORMATION DISCLOSURE STATEMENT BY APPLICANT	ATTY. DOCKET NO. 10901/81	SERIAL NO. Not Yet Assigned
	APPLICANT Roman WOYZICHKOVSKI	
	FILING DATE Herewith	GROUP To be assigned

U. S. PATENT DOCUMENTS

EXAMINER INITIAL	PATENT NUMBER	PATENT DATE	NAME	CLASS	SUBCLASS	FILING DATE
/J.P./	5,644,514**	July 1, 1997	Mitsuyoshi et al.			
/J.P./	5,220,275*	June 15, 1993	Holmovist			
/J.P./	5,677,686*	October 14, 1997	Aoki et al.			
/J.P./	5,783,925**	July 21, 1997	Wise			
/J.P./	5,963,160**	October 5, 1999	Wilson et al.			
/J.P./	5,920,494**	July 6, 1999	Setbacken et al.			
	5,734,688**	March 31, 1998	Teraguchi et al.			
/J.P./	5,485,152**	January 16, 1996	Wilson et al.			
/J.P./	5,142,226**	August 25, 1992	Sakamoto et al.			

* - copy of reference not enclosed, cited in International Search Report and copy provided by searching authority.

** - copy not provided pursuant to Official Gazette Notice dated August 5, 2003.

FOREIGN PATENT DOCUMENTS

EXAMINER INITIAL	DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION	
						YES	NO
	199 38 802**	February 22, 2001	DE				
	0 875 735**	November 4, 1998	EP				
	198 22 843	November 25, 1999	DE				
	100 25 160	December 6, 2001	DE				
	199 34 478	February 8, 2001	DE				
	0 484 576	May 13, 1992	EP				
	0 997 701	May 3, 2000	EP				
	195 02 276	August 1, 1996	DE				
	0 874 223	October 28, 1998	EP				
	0 669 517	August 30, 1995	EP				
	0 599 175	June 1, 1994	EP				
/J.P./	195 06 276**	September 5, 1996	DE				
/J.P./	199 11 822**	August 24, 2000	DE				
/J.P./	196 05 472**	March 8, 2001	DE				

EXAMINER INITIAL	DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION	
						YES	NO
/J.P./	195 44 948***	September 26, 2002	DE				
/J.P./	0 724 137	July 18, 2001	EP				
/J.P./	0 711 974	September 26, 2001	EP				
/J.P./	197 04 132***	August 7, 1997	DE				

* - Copy of reference not enclosed, cited in International Search Report and copy provided by searching authority.

** - Mentioned in the specification.

*** - English-language abstract included herewith.

OTHER DOCUMENTS

EXAMINER INITIAL	AUTHOR, TITLE, DATE, PERTINENT PAGES, ETC.
	M. Peuker, "Optimum energy for high resolution low voltage electron beam lithography - Monte Carlo simulations and experiments", Microelectronic Engineering, , Bd. 53, Nr. 1-4, June 2000, pp. 337-340."

** copy of reference not enclosed, cited in International Search Report and copy provided by searching authority.

EXAMINER	/Jason Perilla/	DATE CONSIDERED	07/17/2007
EXAMINER: Initial if citation considered, whether or not citation is in conformance with M.P.E.P. 609; draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.			



INFORMATION DISCLOSURE STATEMENT BY APPLICANT	ATTY. DOCKET NO. 10901/81	SERIAL NO. 10/501,310
	APPLICANT Roman WOYZICHKOVSKI	
	FILING DATE Nov. 23, 2004	GROUP To be assigned

U. S. PATENT DOCUMENTS

EXAMINER INITIAL	PATENT NUMBER	PATENT DATE	NAME	CLASS	SUBCLASS	FILING DATE
/J.P./	5,706,219 *	Jan. 16, 1998	Ishimoto			
/J.P./	5,999,113 *	Dec. 7, 1999	Kiriyama et al.			
/J.P./	6,534,969 *	Mar. 18, 2003	Dietmayer			
/J.P./	6,188,341 *	Feb. 13, 2001	Taniguchi et al.			
/J.P./	5,625,310 *	Apr. 29, 1997	Takeishi			
/J.P./	5,485,407 *	Jan. 16, 1996	Ishimoto et al.			

* - copy not provided pursuant to Official Gazette Notice dated August 5, 2003.

FOREIGN PATENT DOCUMENTS

EXAMINER INITIAL	DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION	
						YES	NO

OTHER DOCUMENTS

EXAMINER INITIAL	AUTHOR, TITLE, DATE, PERTINENT PAGES, ETC.

EXAMINER /Jason Perilla/	DATE CONSIDERED 07/17/2007
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